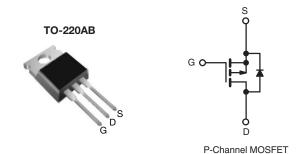


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	- 200				
R _{DS(on)} (Ω)	V _{GS} = - 10 V	1.5			
Q _g (Max.) (nC)	22				
Q _{gs} (nC)	12				
Q _{gd} (nC)	10				
Configuration	Single				



FEATURES

- · Dynamic dV/dt Rating
- P-Channel
- Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC





DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRF9620PbF
Leau (Fb)-liee	SiHF9620-E3
SnPb	IRF9620
SIFD	SiHF9620

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	- 200	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	V _{GS} at - 10 V	T _C = 25 °C		- 3.5	А	
		T _C = 100 °C	I _D	- 2.0		
Pulsed Drain Current ^a			I _{DM}	- 14	1	
Linear Derating Factor				0.32	W/°C	
Maximum Power Dissipation T _C = 25 °C			P _D	40	W	
Peak Diode Recovery dV/dtb	dV/dt	- 5.0	V/ns			
Operating Junction and Storage Temperature Rang	T _J , T _{stg}	- 55 to + 150	00			
Soldering Recommendations (Peak Temperature)	for 10 s			300°	°C	
Manustina Tanana	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $I_{SD} \le$ 3.5 A, $dI/dt \le$ 95 A/µs, $V_{DD} \le V_{DS}, T_J \le$ 150 °C.
- c. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	62			
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.1			

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		1					
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA		- 200	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = -1 mA		- 0.22	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = 0$	V _{GS} , I _D = - 250 μA	- 2.0	-	- 4.0	V
Gate-Source Leakage	I _{GSS}	\	/ _{GS} = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		- 200 V, V _{GS} = 0 V	-	-	- 100	μА
	1055	+	V, V _{GS} = 0 V, T _J = 125 °C	-	-	- 500	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D = - 1.5 A ^b	-	-	1.5	Ω
Forward Transconductance	9fs	$V_{DS} = -$	$50 \text{ V}, I_D = -1.5 \text{ A}^b$	1.0	-	-	S
Dynamic							
Input Capacitance	C_{iss}		$V_{GS} = 0 V$,	-	350	-	
Output Capacitance	C _{oss}	\	$I_{DS} = -25 \text{ V},$	-	100	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1.0	0 MHz, see fig. 5	-	30	-	1
Total Gate Charge	Qg			-	-	22	
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V	I _D = - 4.0 A, V _{DS} = - 160 V, see fig. 11 and 18 ^b	-	-	12	nC
Gate-Drain Charge	Q _{gd}		occong. Trana to	-	-	10	
Turn-On Delay Time	t _{d(on)}	V_{DD} = - 100 V, I_D = - 1.5 A, R_g = 50 Ω , R_D = 67 Ω , see fig. 17 ^b		-	15	-	ns
Rise Time	t _r			-	25	-	
Turn-Off Delay Time	t _{d(off)}			-	20	-	
Fall Time	t _f			-	15	-	
Internal Drain Inductance	L _D	,	Between lead, 6 mm (0.25") from		4.5	-	
Internal Source Inductance	L _S	package and center of die contact		-	7.5	-	nH
Drain-Source Body Diode Characteristic	s	1				L	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	- 3.5	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	- 14	A
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = - 3.5 A, V _{GS} = 0 V ^b		-	-	- 7.0	V
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = - 3.5 A, dI/dt = 100 A/μs ^b		-	300	450	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.9	2.9	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	n-on is dominated by L _S and L _D)			L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

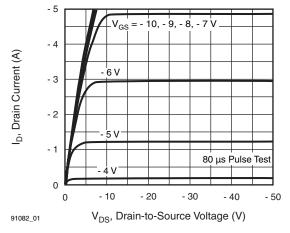


Fig. 1 - Typical Output Characteristics

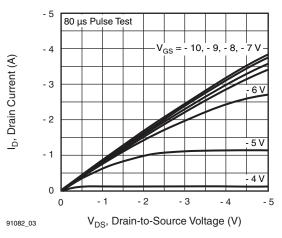


Fig. 3 - Typical Saturation Characteristics

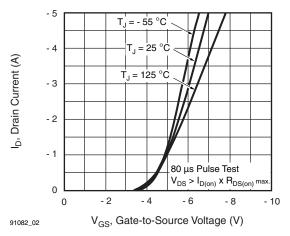


Fig. 2 - Typical Transfer Characteristics

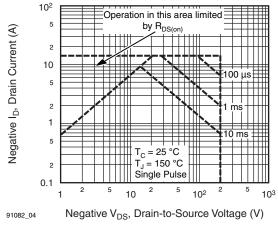


Fig. 4 - Maximum Safe Operating Area

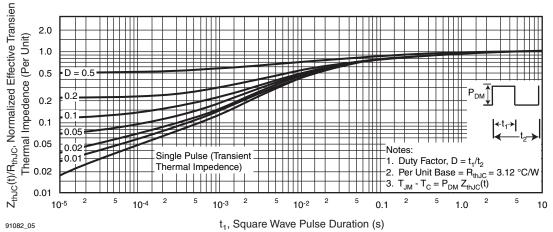


Fig. 5 - Maximum Effective Transient Thermal Impedance, Junction-to-Case vs. Pulse Duration



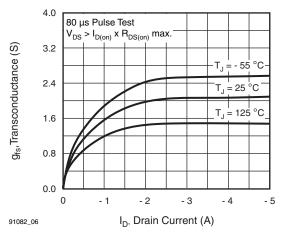


Fig. 6 - Typical Transconductance vs. Drain Current

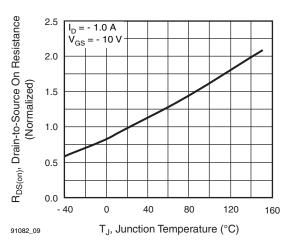


Fig. 9 - Normalized On-Resistance vs. Temperature

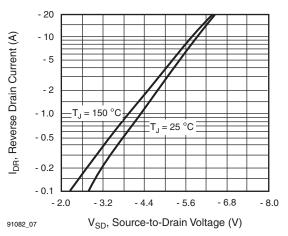


Fig. 7 - Typical Source-Drain Diode Forward Voltage

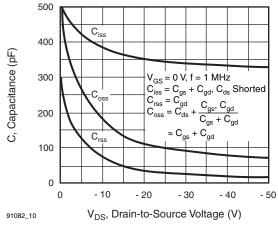


Fig. 10 - Typical Capacitance vs. Drain-to-Source Voltage

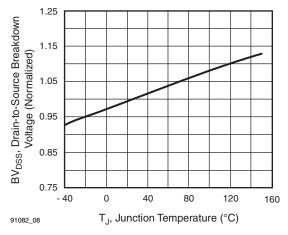


Fig. 8 - Breakdown Voltage vs. Temperature

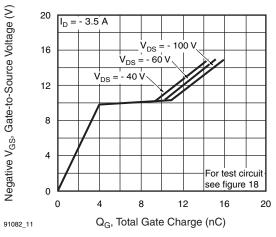


Fig. 11 - Typical Gate Charge vs. Gate-to-Source Voltage



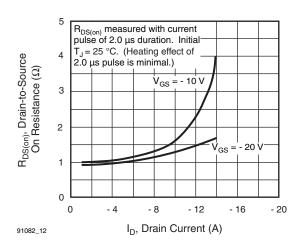


Fig. 12 - Typical On-Resistance vs. Drain Current

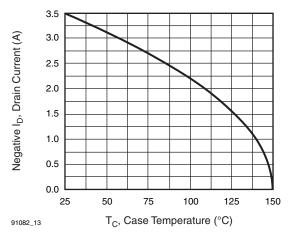


Fig. 13 - Maximum Drain Current vs. Case Temperature

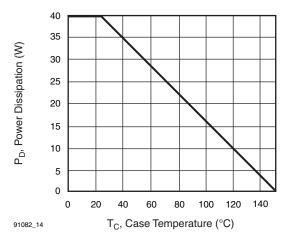


Fig. 14 - Power vs. Temperature Derating Curve

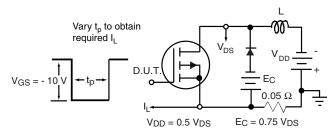


Fig. 15 - Clamped Inductive Test Circuit

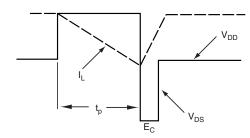


Fig. 16 - Clamped Inductive Waveforms

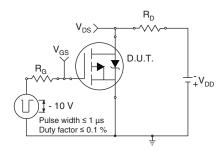


Fig. 17a - Switching Time Test Circuit

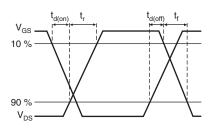


Fig. 17b - Switching Time Waveforms



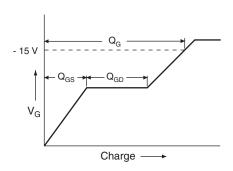


Fig. 18a - Basic Gate Charge Waveform

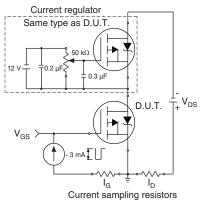
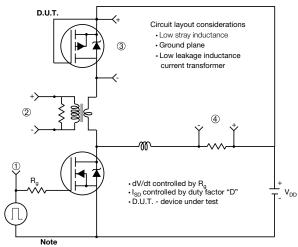


Fig. 18b - Gate Charge Test Circuit

Peak Diode Recovery dV/dt Test Circuit



Compliment N-Channel of D.U.T. for driver

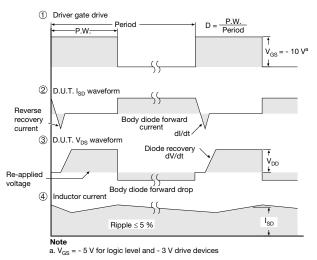


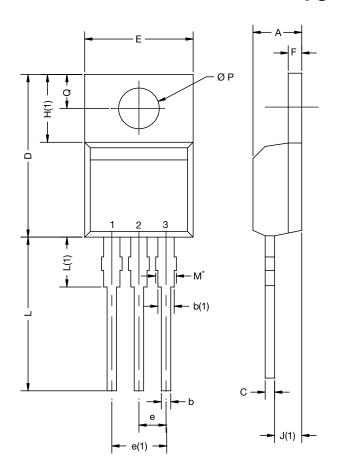
Fig. 19 - For P-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91082.





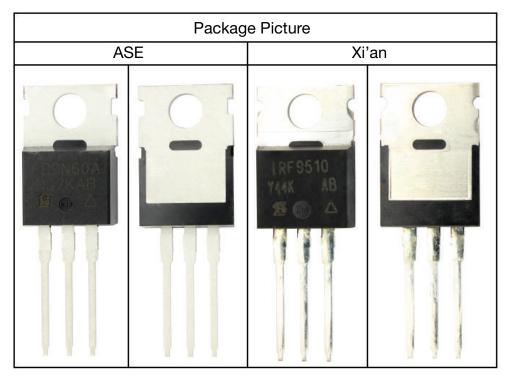
TO-220-1



DIM.	MILLIM	IETERS	INCHES			
Dilvi.	MIN.	MAX.	MIN.	MAX.		
Α	4.24	4.65	0.167	0.183		
b	0.69	1.02	0.027	0.040		
b(1)	1.14	1.78	0.045	0.070		
С	0.36	0.61	0.014	0.024		
D	14.33	15.85	0.564	0.624		
Е	9.96	10.52	0.392	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.10	6.71	0.240	0.264		
J(1)	2.41	2.92	0.095	0.115		
L	13.36	14.40	0.526	0.567		
L(1)	3.33	4.04	0.131	0.159		
ØР	3.53	3.94	0.139	0.155		
Q	2.54	3.00	0.100	0.118		
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031						

Note

 \bullet $M^{\star}=0.052$ inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542

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Vishay

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